

**Search Notes**

Application/Control No.

10/604,555

Examiner

Hae M. Hyeon

Applicant(s)/Patent under  
Reexamination

AUDET ET AL.

Art Unit

2839

**SEARCHED**

Class	Subclass	Date	Examiner
439	66	2/05	hnh
439	78	↓	↓

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
361/760 and 439/876 Text Searched	2/05	hnh